

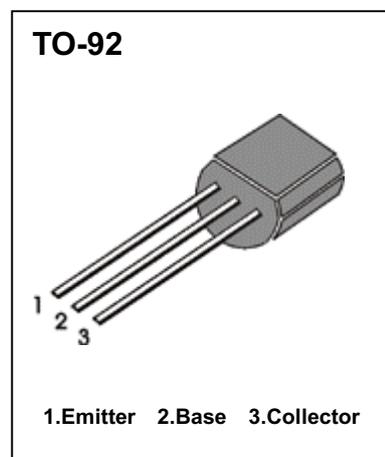
NPN SILICON TRANSISTOR

■ HIGH VOLTAGE TRANSISTORS

- Collector-Emitter Voltage: $V_{CE0}=300V$
- Collector Dissipation: $P_C(\max)=625mW$
- Complementary to MPSA92

■ ABSOLUTE MAXIMUM RATINGS
 $(T_A=25^{\circ}C)$

Characteristic	Symbol	Rating	Unit
Collector Base Voltage	V_{CBO}	300	V
Collector-Emitter Voltage	V_{CEO}	300	V
Emitter-Base Voltage	V_{EBO}	6	V
Collector Current	I_C	500	mA
Collector Dissipation	P_C	625	mW
Junction Temperature	T_J	150	$^{\circ}C$
Storage Temperature	T_{STG}	150	$^{\circ}C$


■ ELECTRICAL CHARACTERISTICS
 $(T_A=25^{\circ}C)$

Characteristic	Symbol	Test Conditions	MIN.	MAX.	Unit
Collector-Base Breakdown Voltage	BV_{CBO}	$I_C=100\mu A, I_E=0$	300		V
*Collector-Emitter Breakdown Voltage	BV_{CEO}	$I_C=1mA, I_B=0$	300		V
Emitter-Base Breakdown Voltage	BV_{EBO}	$I_E=100\mu A, I_C=0$	6		V
Collector Cut-Off Current	I_{CBO}	$V_{CB}=200V, I_E=0$		100	nA
Emitter Cut-off Current	I_{EBO}	$V_{BE}=6V, I_C=0$		100	nA
*DC Current Gain	h_{FE}	$V_{CE}=10V, I_C=1mA$	25		
		$V_{CE}=10V, I_C=10mA$	40		
		$V_{CE}=10V, I_C=30mA$	40		
*Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$I_C=20mA, I_B=2mA$		0.5	V
*Base-Emitter Saturation Voltage	$V_{BE(sat)}$	$I_C=20mA, I_B=2mA$		0.9	V
Collector-Base Capacitance	C_{CB}	$V_{CB}=20V, I_E=0, f=1MHz$		3	pF
Current Gain Bandwidth Product	f_T	$V_{CE}=20V, I_C=10mA, f=100MHz$	50		MHz

*Pulse Test: $PW \leq 300\mu s$, Duty Cycle $\leq 2\%$